

**Search Notes**

Application/Control No.

10/759,199

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

WATANABE ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	160	10/2005	js
430	270.1	L	L
430	302	L	L

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED SEARCH	10/2005	js